Applicant(s)/Patent Under Application/Control No. Reexamination 10/064,777 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 EDWYN LABAZE 2876 **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code MM-YYYY 349/38 US-5,369,512 11-1994 Yanai et al. 349/39 В US-5,459,596 10-1995 Ueda et al. 349/46 С US-5,546,205 08-1996 Sukegawa et al. US-5,668,650 09-1997 Mori et al. 349/42 D E US-US-F US-G US-Н US-1 US-J US-US-L М US-FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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